

October 2008

FDS4897AC

Dual N & P-Channel PowerTrench[®] MOSFET N-Channel: 40 V, 6.1 A, 26 m Ω P-Channel: -40 V, -5.2 A, 39 m Ω

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 26 m Ω at V_{GS} = 10 V, I_D = 6.1 A
- Max $r_{DS(on)}$ = 31 m Ω at V_{GS} = 4.5 V, I_D = 5.6 A

Q2: P-Channel

- Max $r_{DS(on)}$ = 39 m Ω at V_{GS} = -10 V, I_D = -5.2 A
- Max $r_{DS(on)}$ = 65 m Ω at V_{GS} = -4.5 V, I_D = -4.1 A
- 100% UIL Tested
- RoHS Compliant

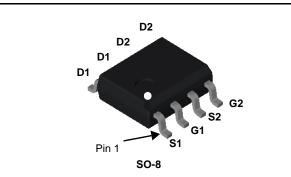


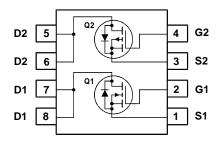
General Description

These dual N- and P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

Applications

- Inverter
- Power Supplies





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Q1	Q2	Units
V _{DS}	Drain to Source Voltage		40	-40	V	
V _{GS}	Gate to Source Voltage			±20	±20	V
1	Drain Current - Continuous		6.1	-5.2	^	
D	- Pulsed			24	-24	- A
	Power Dissipation for Dual Operation			2.0		
PD	Power Dissipation for Single Operation	T _A = 25 °C	(Note 1a)	1	.6	W
		T _A = 25 °C	(Note 1b)	0	.9	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	37	73	mJ
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to	+150	°C

Thermal Characteristics

R_{\thetaJC}	Thermal Resistance, Junction to Case,	(Note 1)	40	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Ambient,	(Note 1a)	78	0/10

Package Marking and Ordering Information

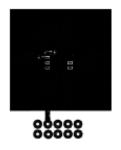
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS4897AC	FDS4897AC	SO-8	13 "	12 mm	2500 units

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Char	acteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$ $I_D = -250 \ \mu A, \ V_{GS} = 0 \ V$	Q1 Q2	40 -40			V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C I_D = -250 μ A, referenced to 25 °C	Q1 Q2		37 -32		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 32 V, V_{GS} = 0 V$ $V_{DS} = -32 V, V_{GS} = 0 V$	Q1 Q2			1 -1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	Q1 Q2			±100 ±100	nA nA
On Char	acteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$ $V_{GS} = V_{DS}, I_D = -250 \ \mu A$	Q1 Q2	1.5 -1.5	2.0 -2.0	3.0 -3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = -250 \ \mu$ A, referenced to 25 °C	Q1 Q2		-6 6		mV/°C
-	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 6.1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 5.6 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6.1 \text{ A}, T_J = 125 \text{ °C}$	Q1		20 24 30	26 31 39	- mΩ
r _{DS(on)}	Static Drain to Source On Resistance		Q2		28 45 41	39 65 57	11152
9 _{FS}	Forward Transconductance	$V_{DD} = 5 V, I_D = 6.1 A$ $V_{DD} = -5 V, I_D = -5.2 A$	Q1 Q2		24 14		S
Dynamic	Characteristics	1	• •				1
C _{iss}	Input Capacitance	Q1 V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		795 765	1055 1015	pF
C _{oss}	Output Capacitance	Q2	Q1 Q2		95 135	130 180	pF
0	Reverse Transfer Capacitance	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHZ}$	Q1		65	100	_
C _{rss}			Q2		80	120	pF
R _g	Gate Resistance		Q2 Q1 Q2		80 1.7 3.6		pF Ω
R _g			Q1		1.7		
R _g Switchin	Gate Resistance	Q1	Q1		1.7		
R _g Switchin t _{d(on)}	Gate Resistance	Q1 $V_{DD} = 20 \text{ V}, \text{ I}_{D} = 6.1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2 Q1		1.7 3.6 6	120	Ω
R _g Switchin t _{d(on)} t _r	Gate Resistance g Characteristics Turn-On Delay Time	$V_{DD} = 20 V, I_D = 6.1 A,$ $V_{GS} = 10 V, R_{GEN} = 6 \Omega$ Q2	Q1 Q2 Q1 Q2 Q1 Q1		1.7 3.6 6 8 2	120 12 12 15 10	Ω ns
R _g Switchin t _{d(on)} t _r t _{d(off)}	Gate Resistance Ig Characteristics Turn-On Delay Time Rise Time	V_{DD} = 20 V, I _D = 6.1 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	Q1 Q2 Q1 Q2 Q1 Q2 Q1 Q2 Q1		1.7 3.6 6 8 2 3 17	120 12 15 10 10 30	Ω ns ns
R_g Switchin $t_{d(on)}$ t_r $t_{d(off)}$ t_f	Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{DD} = 20 \text{ V}, \text{ I}_{D} = 6.1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $Q2$ $V_{DD} = -20 \text{ V}, \text{ I}_{D} = -5.2 \text{ A},$ $V_{GS} = -10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $Q1$	Q1 Q2 Q1 Q2 Q1 Q2 Q1 Q2 Q1 Q2 Q1		1.7 3.6 6 8 2 3 17 17 17 2	120 12 15 10 10 30 30 30 10	Ω ns ns ns
R _g	Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{DD} = 20 \text{ V}, \text{ I}_{D} = 6.1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $Q2$ $V_{DD} = -20 \text{ V}, \text{ I}_{D} = -5.2 \text{ A},$ $V_{GS} = -10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2 Q1 Q2 Q1 Q2 Q1 Q2 Q1 Q2 Q1 Q2 Q1 Q2 Q1		1.7 3.6 6 8 2 3 17 17 17 2 3 15	120 12 15 10 10 30 30 30 10 10 10 21	ns ns ns ns

2

Symbol	Parameter	Test Conditions		Туре	Min	Тур	Max	Units
Drain-S	ource Diode Characteristics							
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 1.3 A$ $V_{GS} = 0 V, I_S = -1.3 A$	(Note 2) (Note 2)	Q1 Q2		0.75 -0.76	1.2 -1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 6.1 A, di/dt = 100 A/s		Q1 Q2		17 20	31 36	ns
Q _{rr}	Reverse Recovery Charge	Q_2 I _F = -5.2 A, di/dt = 100 A/s		Q1 Q2		7 10	15 20	nC

Notes:
 I: R_{0JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



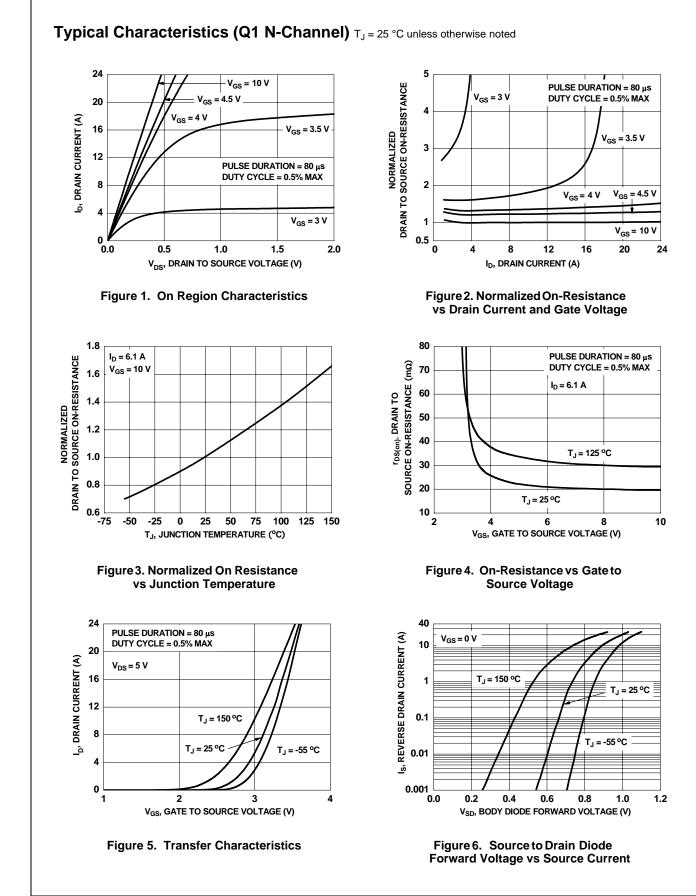
a) 78 °C/W when mounted on a 1 in² pad of 2 oz copper



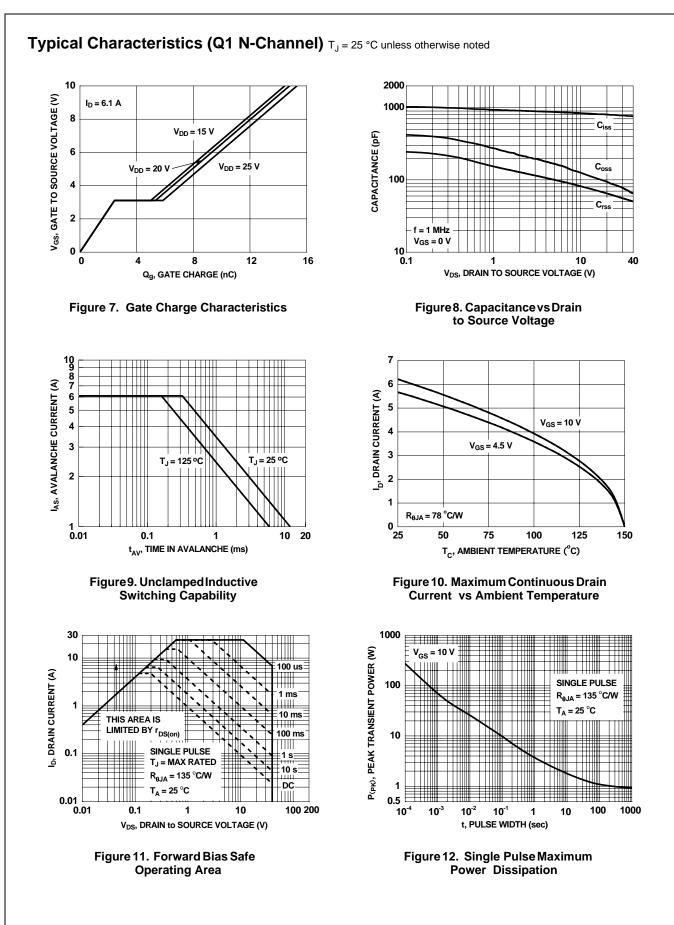
b) 135 °C/W when mounted on a minimun pad

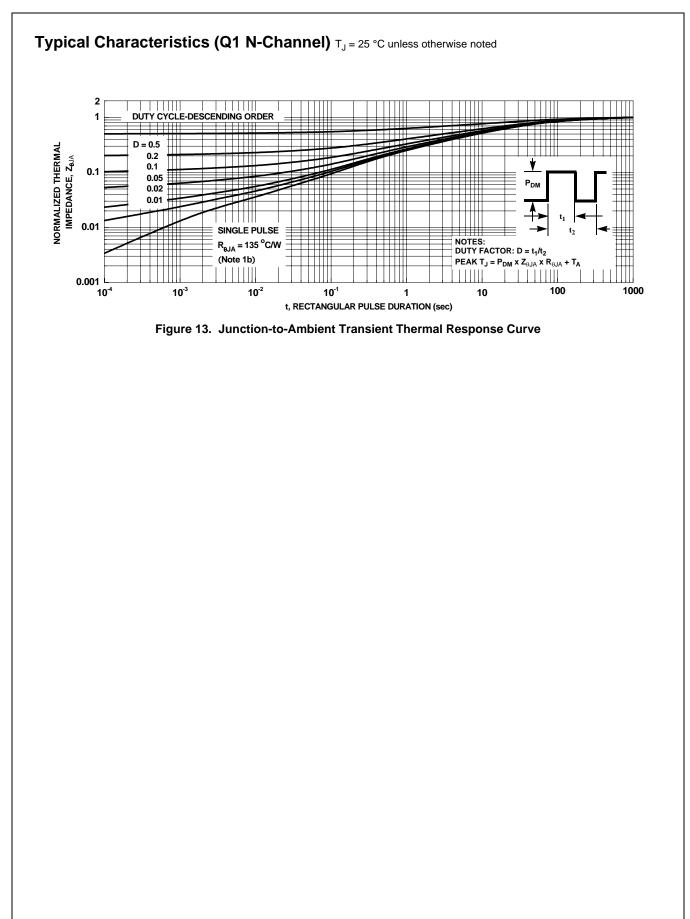
2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3: Starting T_J = 25 °C, N-ch: L = 3 mH, I_{AS} = 5 A, V_{DD} = 40 V, V_{GS} = 10 V; P-ch: L = 3 mH, I_{AS} = -7 A, V_{DD} = -40 V, V_{GS} = -10 V.

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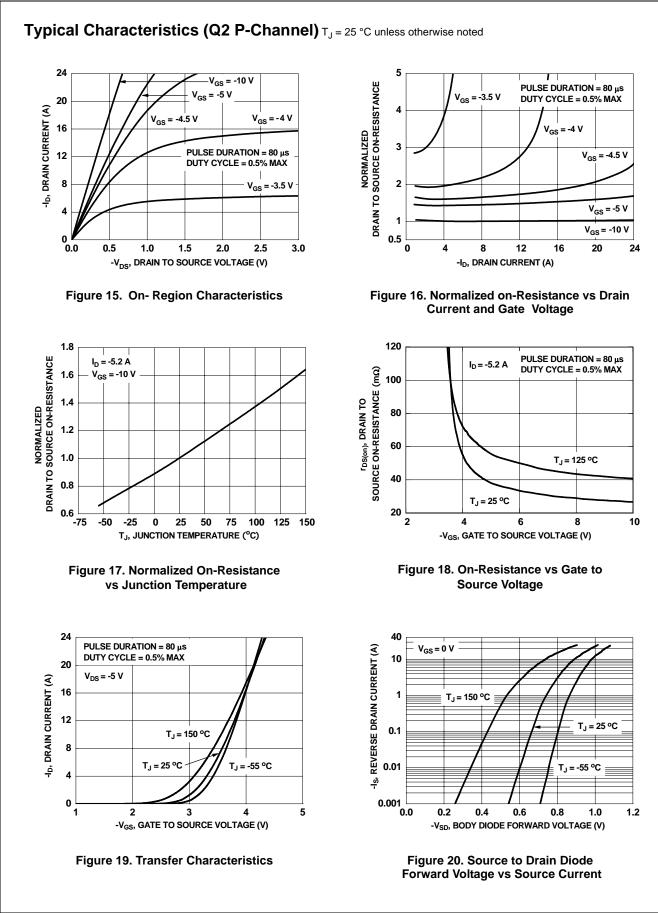


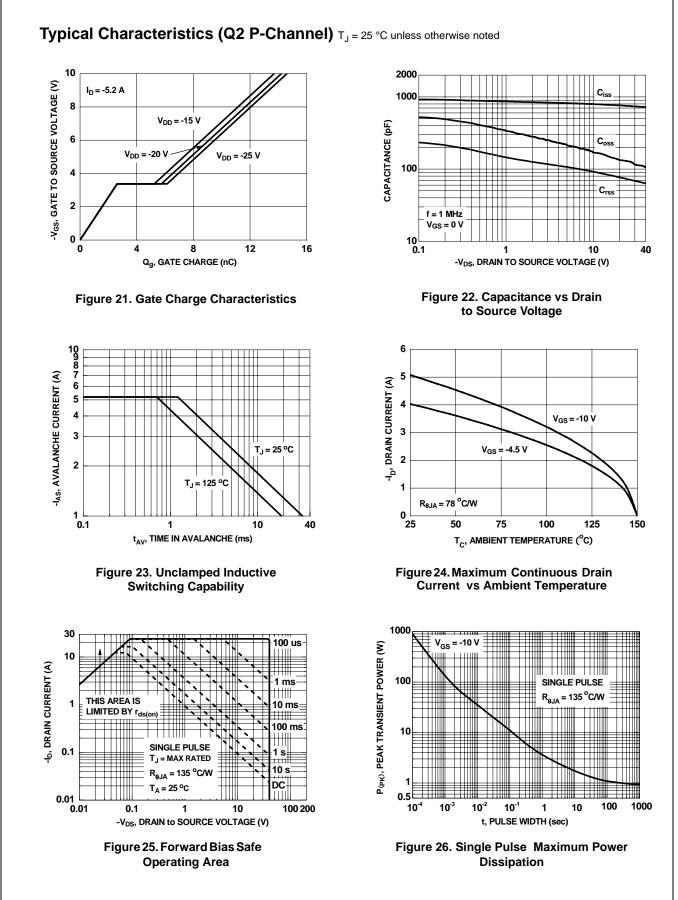


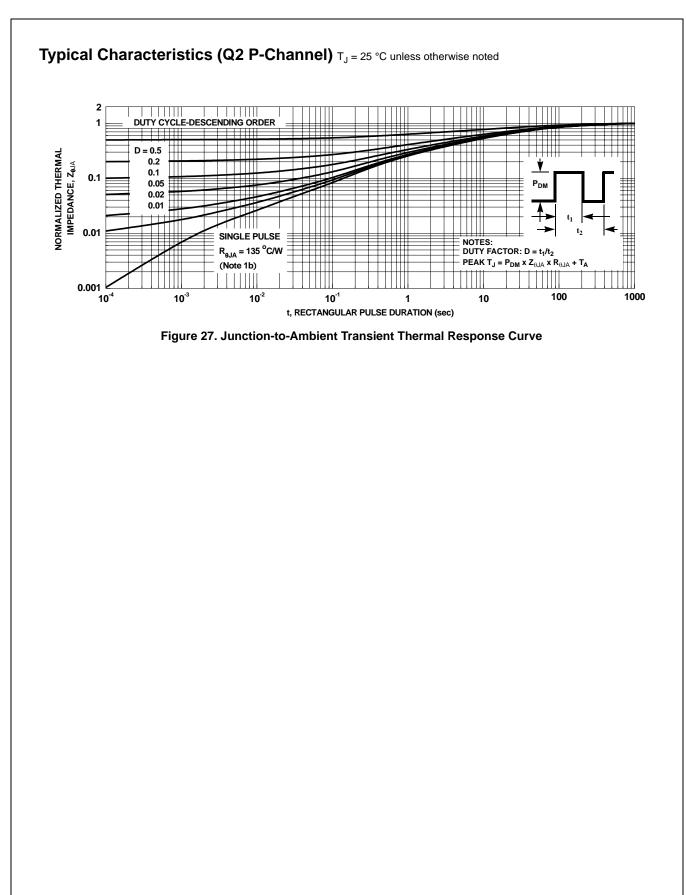




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